

INVENTOR INFORMATION

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CORRESPONDENCE INFORMATION

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APPLICATION INFORMATION

Title Line One:: SEMICONDUCTOR DEVICE TESTING APPARATUS A  
Title Line Two:: ND TEST METHOD THEREFOR  
Total Drawing Sheets:: 5  
Formal Drawings?:: No  
Application Type:: Utility  
Docket Number:: A-392  
Secrecy Order in Parent Appl.?:: No

REPRESENTATIVE INFORMATION

Representative Customer Number:: 802  
Registration Number One:: 35731

PRIOR FOREIGN APPLICATIONS

Foreign Application One:: 2000-113071  
Filing Date:: 04-14-2000  
Country:: JAPAN  
Priority Claimed:: Yes

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